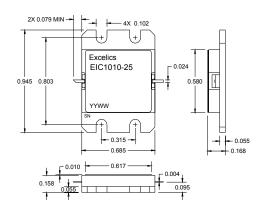


FEATURES

- 10.0 10.25 GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +44 dBm Output Power at 1dB Compression
- 7 dB Power Gain at 1dB Compression
- 33% Power Added Efficiency
- **Hermetic Metal Flange Package**
- 100% Tested for DC, RF, and R_{TH}



ELECTRICAL CHARACTERISTICS (T_a = 25°C)



Caution! ESD sensitive device.

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 4000\text{mA}$	43	44		dBm
G _{1dB}	Gain at 1dB Compression $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 4000\text{mA}$	6.5	7		dB
ΔG	Gain Flatness $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 4000\text{mA}$			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression $V_{DS} = 9 \text{ V}$, $I_{DSQ} \approx 4000 \text{mA}$ f = 10.0-10.25GHz		33		%
Id _{1dB}	Drain Current at 1dB Compression f = 10.0-10.25GHz		6500	7200	mA
I _{DSS}	Saturated Drain Current V _{DS} = 3 V, V _{GS} = 0 V		11	16	Α
V _P	Pinch-off Voltage V _{DS} = 3 V, I _{DS} = 130 mA		-2.5	-4.0	V
R _{TH}	Thermal Resistance ²		1.4	1.8	°C/W

- Tested with 15 Ohm gate resistor, forward and reverse gate current should not exceed 105mA and -10.5mA respectively
- Overall Rth depends on case mounting.

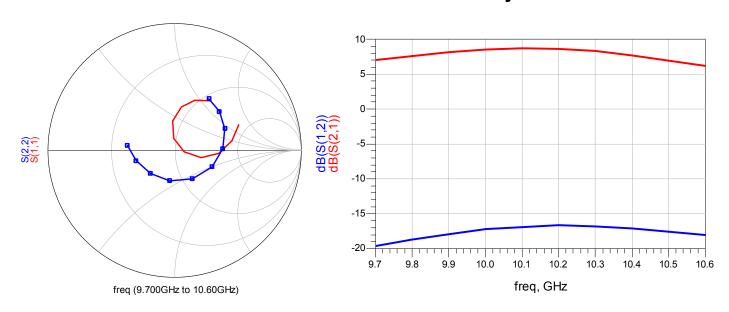
MAXIMUM RATING AT 25°C1,2

SYMBOLS	PARAMETERS	ABSOLUTE ¹	CONTINUOUS ²				
Vds	Drain-Source Voltage	15	10V				
Vgs	Gate-Source Voltage	-5	-4V				
Pin	Input Power	38.5 dBm	@ 3dB Compression				
Tch	Channel Temperature	175 °C	175 °C				
Tstg	Storage Temperature	-65 to +175 °C	-65 to +175 °C				
Pt	Total Power Dissipation	83W	83W				

Note: 1. Exceeding any of the above ratings may result in permanent damage.

2. Exceeding any of the above ratings may reduce MTTF below design goals.

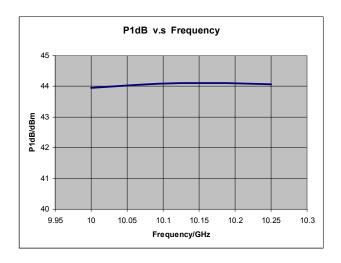


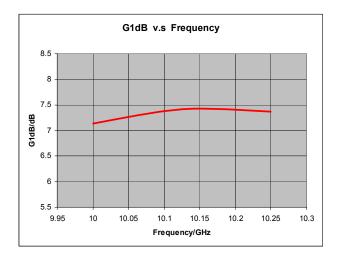


Frequency	S11		S21		S12		S22	
GHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
9.7	0.542	21.8	0.104	-48.9	2.238	0.3	0.488	56.5
9.8	0.457	9.2	0.116	-65.0	2.398	-15.2	0.467	41.0
9.9	0.349	-4.0	0.127	-81.8	2.551	-31.9	0.432	23.5
10	0.218	-15.3	0.138	-100.3	2.675	-50.2	0.379	2.1
10.1	0.077	-9.8	0.143	-119.5	2.731	-69.2	0.322	-23.9
10.2	0.095	96.3	0.147	-139.0	2.684	-89.1	0.264	-58.3
10.3	0.232	94.4	0.144	-158.3	2.597	-107.8	0.243	-99.5
10.4	0.346	81.5	0.139	-176.3	2.42	-126.4	0.265	-136.7
10.5	0.428	67.9	0.132	166.7	2.212	-143.3	0.317	-165.0
10.6	0.479	54.5	0.125	150.6	2.029	-159.8	0.377	174.3

Typical S-Parameters (T= 25°C, 50 Ω system, de-embedded to edge of package) V_{DS} = 9 V, I_{DSQ} \approx 4000mA



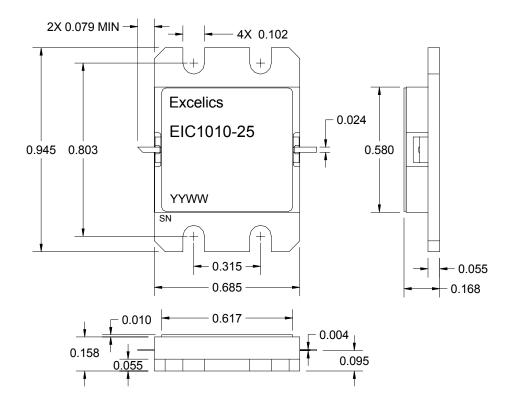




 $V_{DS} = 9 V, I_{DSQ} \approx 4000 mA$

PACKAGE OUTLINE

Dimensions in inches, Tolerance ± .005 unless otherwise specified







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- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.